Notice	of Refere	nces Cited
--------	-----------	------------

10/700 070		Applicant(s)/Patent Under Reexamination JIN ET AL.		
	Examiner	Art Unit		
	JOHN LEE	2624	Page 1 of 1	

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,175,379 B1	01-2001	Uomori et al.	348/47
*	В	US-2002/0024516 A1	02-2002	Chen et al.	345/419
*	С	US-2003/0113018 A1	06-2003	Nefian et al.	382/181
*	D	US-2003/0197779 A1	10-2003	Zhang et al.	348/14.16
*	Е	US-2004/0189720 A1	09-2004	Wilson et al.	345/863
*	F	US-2004/0193413 A1	09-2004	Wilson et al.	704/243
*	G	US-7,224,357 B2	05-2007	Chen et al.	345/420
	н	US-		-	
	_	US-			
	J	US-			
	к	US-			
	L	US-			
	м	US-			

## FOREIGN PATENT DOCUMENTS

	FOREIGN PATENT DOCUMENTS					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	т					

## NON-PATENT DOCUMENTS

	NON-FAIENT DOCUMENTS				
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	٧				
	w				
	х				

"A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.